## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | YEH ET AL. | Examiner | Art Unit | Stanetta D. Isaac | 2812 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,689,647	02-2004	Joo et al.	438/151
	В	US-6,100,119	08-2000	Jang et al.	438/151
	С	US-5,589,406	12-1996	Kato et al.	438/164
	D	US-2004/0026738	02-2004	Hasegawa, Hisashi	257/347
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	V 10				
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	٧	,
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.